

SAMSUNG SEMICONDUCTOR INC 14E D 7964142 0007244 8  
**MMBC1622D7 NPN EPITAXIAL SILICON TRANSISTOR**

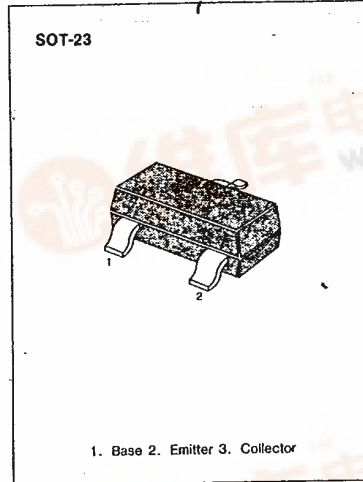
T-29-19

**AMPLIFIER TRANSISTOR**

**ABSOLUTE MAXIMUM RATINGS (T<sub>a</sub> = 25°C)**

Characteristic	Symbol	Rating	Unit
Collector-Base Voltage	V <sub>CB0</sub>	40	V
Collector-Emitter Voltage	V <sub>CEO</sub>	35	V
Emitter-Base Voltage	V <sub>EB0</sub>	5.0	V
Collector Current	I <sub>C</sub>	100	mA
Collector Dissipation	P <sub>C</sub>	350	mW
Storage Temperature	T <sub>stg</sub>	150	°C

• Refer to MMBC1622D6 for graphs



1. Base 2. Emitter 3. Collector

**ELECTRICAL CHARACTERISTICS (T<sub>a</sub> = 25°C)**

Characteristic	Symbol	Test Condition	Min	Max	Unit
Collector Cutoff Current	I <sub>CB0</sub>	V <sub>CB</sub> = 25V, I <sub>E</sub> = 0		50	nA
Emitter Cutoff Current	I <sub>EB0</sub>	V <sub>EB</sub> = 5V, I <sub>C</sub> = 0		50	nA
DC Current Gain	h <sub>FE</sub>	V <sub>CE</sub> = 3V, I <sub>C</sub> = 0.1mA	150		
		V <sub>CE</sub> = 3V, I <sub>C</sub> = 0.5mA	300	600	
Collector-Emitter Saturation Voltage	V <sub>CE(sat)</sub>	I <sub>C</sub> = 100mA, I <sub>B</sub> = 10mA		0.3	V
Base-Emitter On Voltage	V <sub>BE(on)</sub>	I <sub>C</sub> = 0.5mA, V <sub>CE</sub> = 3V	0.55	0.65	V
Current Gain-Bandwidth Product	f <sub>T</sub>	V <sub>CE</sub> = 6V, I <sub>E</sub> = 1mA f = 100MHz	100		MHz

**Marking**

